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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/666,374	ZEIRA ET AL.	
Examiner	Art Unit	
Dai A. Phuong	2688	

SEARCHED			
Class	Subclass	Date	Examiner
455	436-444	3/2/2006	al,
	455	3/2/2006	
	456.4	3/2/2006	
370	328-333	3/2/2006	7
	335338	3/2/2006	all
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	·)
	DATE	EXMR
East Search Attached	3/2/2006	al
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